

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







Self-Protected Low Side Driver with Temperature and Current Limit

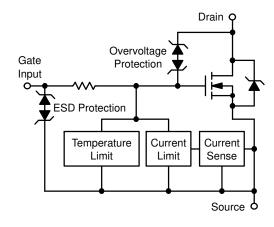
NCV8402/A is a three terminal protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

Features

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- NCV8402AMNWT1G Wettable Flanks Product
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial





ON Semiconductor®

www.onsemi.com

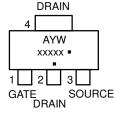
V _{(BR)DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX
42 V	165 mΩ @ 10 V	2.0 A*

^{*}Max current limit value is dependent on input condition.

MARKING DIAGRAMS



SOT-223 CASE 318E STYLE 3





DFN6 CASE 506AX





DFN6 (WF) CASE 506DK



A = Assembly Location

Y = Year

W or WW = Work Week xxxxx = V8402 or 8402A • Pb-Free Package

(Note: Microdot may be in either location)

DFN6 PACKAGE PIN DESCRIPTION

G	NC	NC	
1	2	3	
_	7	- ,	
	, EPAI	5	
		_	
6	5	4	
S	S	S	
J	0	J	

Pin#	Symbol	Description
1	G	Gate Input
2	NC	No Connect
3	NC	No Connect
4	S*	Source
5	S*	Source
6	S*	Source
7	EPAD	Drain

*Pins 4, 5, 6 are internally shorted together. It is recommended to short these pins externally.

ORDERING INFORMATION

See detailed ordering and shipping information on page 11 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

	Rating		Symbol	Value	Unit		
Drain-to-Source Voltage Internally Clamped				42	V		
Drain-to-Gate Voltage Internally Cl	amped	$(R_G = 1.0 M\Omega)$	V_{DGR}	42	V		
Gate-to-Source Voltage			V_{GS}	±14	V		
Continuous Drain Current			I _D	Internally L	Internally Limited		
Total Power Dissipation – SOT–223	3 Version	@ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2) @ T _S = 25°C)	P _D	1.1 1.7 8.9	W		
Total Power Dissipation – DFN Vers	@ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2) @ T _S = 25°C)	P _D	0.76 1.7 8.9	W			
Maximum Continuous Drain Curren	@ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2) @ T _S = 25°C)	I _D	2.37 2.98 6.75	А			
Maximum Continuous Drain Current – DFN Version			Ι _D	1.98 3.02 6.75	Α		
Thermal Resistance	sermal Resistance SOT223 Junction-to-Ambient Steady State (Note 1) SOT223 Junction-to-Ambient Steady State (Note 2) SOT223 Junction-to-Soldering Point Steady State		$egin{array}{l} R_{ hetaJA} \ R_{ hetaJS} \end{array}$	114 72 14	°C/W		
DFN Junction-to-Ambient Steady State (Note 1) DFN Junction-to-Ambient Steady State (Note 2) DFN Junction-to-Soldering Point Steady State			$egin{aligned} R_{ hetaJA} \ R_{ hetaJS} \end{aligned}$	163 70 14			
Single Pulse Drain-to–Source Avalanche Energy (VDD = 32 V, VG = 5.0 V, IPK = 1.0 A, L = 300 mH, $R_{G(ext)}$ = 25 Ω)			E _{AS}	150	mJ		
Load Dump Voltage $(V_{GS} = 0 \text{ and } 10 \text{ V}, R_I = 2.0 \Omega, R_L = 9.0 \Omega, t_d = 400 \text{ ms})$				55	V		
Operating Junction Temperature			T _J	-40 to 150	°C		
Storage Temperature			T _{stg}	-55 to 150	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

2. Surface—mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

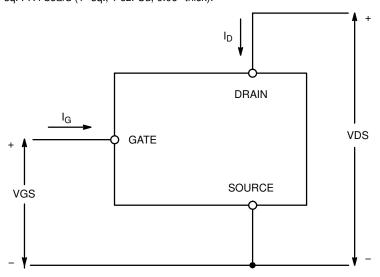


Figure 1. Voltage and Current Convention

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
	CHARACTERISTICS		IVIIII	Тур	IVIAX	Oiiit
Drain-to-Source Breakdown Voltage	V0VI10 mA T25°C	V	40	46	55	V
(Note 3)	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$ $V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$	V _{(BR)DSS}	42	46 45	55	- '
Zero Gate Voltage Drain Current	(Note 5) V _{GS} = 0 V, V _{DS} = 32 V, T _J = 25°C	I _{DSS}		0.25	4.0	μΑ
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 150^{\circ}\text{C}$	I _{DSS}		1.1	20	μΑ
Zero date voltage Brain Guirent	(Note 5)	פטי		1.1	20	μΛ
Gate Input Current	$V_{DS} = 0 \text{ V}, V_{GS} = 5.0 \text{ V}$	I _{GSSF}		50	100	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 150 \mu A$	V _{GS(th)}	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V _{GS(th)} /T _J		4.0		-mV/°C
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$	R _{DS(on)}		165	200	mΩ
	V _{GS} = 10 V, I _D = 1.7 A, T _J = 150°C (Note 5)			305	400	
	$V_{GS} = 5.0 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$			195	230	
	$V_{GS} = 5.0 \text{ V}, I_D = 1.7 \text{ A}, T_J = 150^{\circ}\text{C}$ (Note 5)			360	460	
	V _{GS} = 5.0 V, I _D = 0.5 A, T _J = 25°C			190	230	1
	$V_{GS} = 5.0 \text{ V}, I_D = 0.5 \text{ A}, T_J = 150^{\circ}\text{C}$ (Note 5)			350	460	
Source-Drain Forward On Voltage	$V_{GS} = 0 \text{ V}, I_S = 7.0 \text{ A}$	V_{SD}		1.0		V
SWITCHING CHARACTERISTICS (Note	5)			•		•
Turn–On Delay Time (10% $V_{\rm IN}$ to 90% $I_{\rm D}$)		td _(on)		25	30	μs
Turn-On Rise Time (10% I _D to 90% I _D)		t _{rise}		120	200	μS
Turn-Off Delay Time (90% V _{IN} to 10% I _D)	$V_{GS} = 10 \text{ V}, V_{DD} = 12 \text{ V}, I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	td _(off)		20	25	μs
Turn-Off Fall Time (90% I _D to 10% I _D)	_	t _{fall}		50	70	μS
Slew-Rate ON (70% to 50% V _{DD})		-dV _{DS} /dt _{ON}		0.8	1.2	V/μs
Slew-Rate OFF (50% to 70% V _{DD})		dV _{DS} /dt _{OFF}		0.3	0.5	V/μs
SELF PROTECTION CHARACTERISTIC	S ($T_J = 25^{\circ}C$ unless otherwise noted) (Note 4)				
Current Limit	$V_{DS} = 10 \text{ V}, V_{GS} = 5.0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I _{LIM}	3.7	4.3	5.0	Α
	V _{DS} = 10 V, V _{GS} = 5.0 V, T _J = 150°C (Note 5)		2.3	3.0	3.7	
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 25°C		4.2	4.8	5.4	1
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 150°C (Note 5)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V _{GS} = 5.0 V (Note 5)	T _{LIM(off)}	150	175	200	°C
Thermal Hysteresis	V _{GS} = 5.0 V	$\Delta T_{LIM(on)}$		15]
Temperature Limit (Turn-off)	ture Limit (Turn–off) V _{GS} = 10 V (Note 5)		150	165	185]
Thermal Hysteresis V _{GS} = 10 V		$\Delta T_{LIM(on)}$		15		
GATE INPUT CHARACTERISTICS (Note	5)					
Device ON Gate Input Current	$V_{GS} = 5 \text{ V I}_{D} = 1.0 \text{ A}$	I _{GON}		50		μΑ
	V _{GS} = 10 V I _D = 1.0 A			400		

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Fault conditions are viewed as beyond the normal operating range of the part.
 Not subject to production testing.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
GATE INPUT CHARACTERISTICS (Note	5)	<u> </u>	- I	l		
Current Limit Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GCL}		0.05		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.4		
Thermal Limit Fault Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GTL}		0.15		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.7		
ESD ELECTRICAL CHARACTERISTICS	(T _J = 25°C unless otherwise noted) (N	ote 5)				
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
	Machine Model (MM)		400			

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{3.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%. 4. Fault conditions are viewed as beyond the normal operating range of the part.

^{5.} Not subject to production testing.

TYPICAL PERFORMANCE CURVES

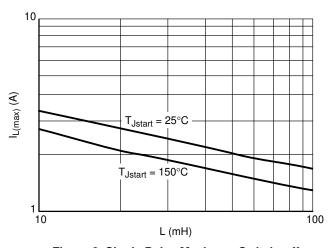


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

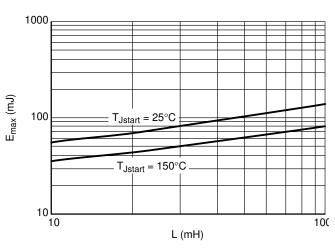


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

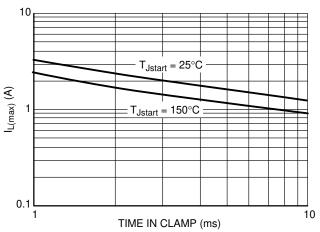


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

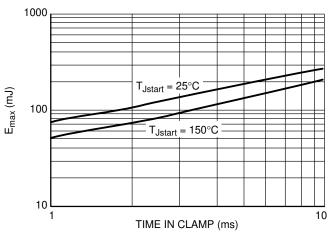


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

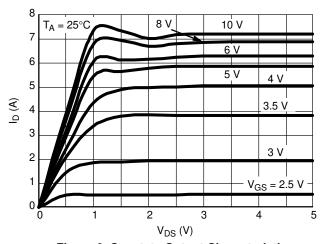


Figure 6. On-state Output Characteristics

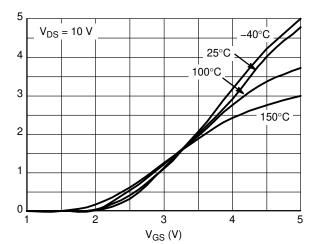


Figure 7. Transfer Characteristics

 $I_D(A)$

TYPICAL PERFORMANCE CURVES

ILIM (A)

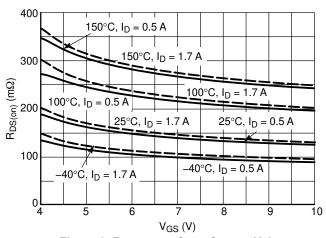


Figure 8. R_{DS(on)} vs. Gate-Source Voltage

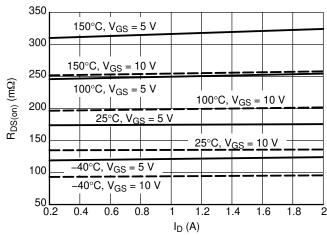


Figure 9. R_{DS(on)} vs. Drain Current

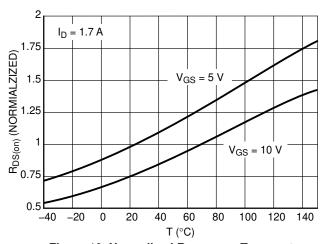


Figure 10. Normalized R_{DS(on)} vs. Temperature

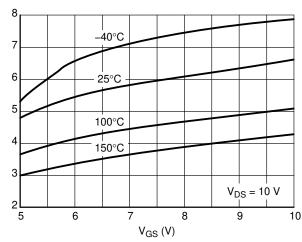


Figure 11. Current Limit vs. Gate-Source Voltage

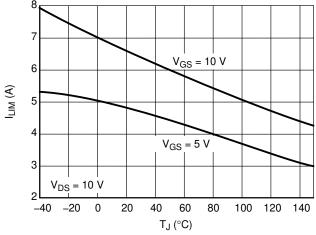


Figure 12. Current Limit vs. Junction Temperature

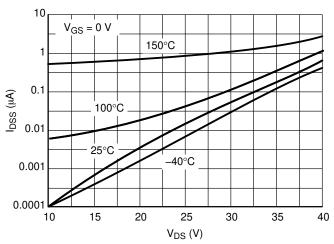


Figure 13. Drain-to-Source Leakage Current

TYPICAL PERFORMANCE CURVES

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

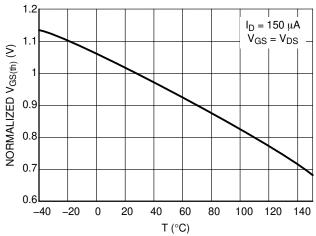


Figure 14. Normalized Threshold Voltage vs. Temperature

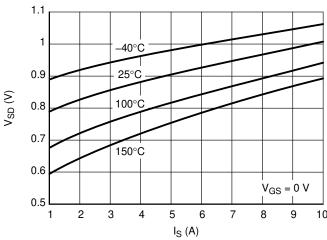


Figure 15. Source–Drain Diode Forward
Characteristics

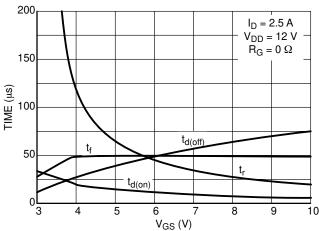


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

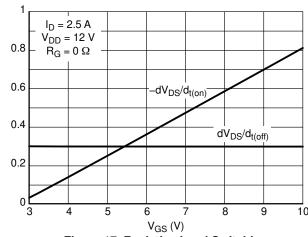


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

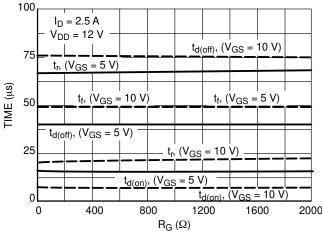


Figure 18. Resistive Load Switching Time vs.
Gate Resistance

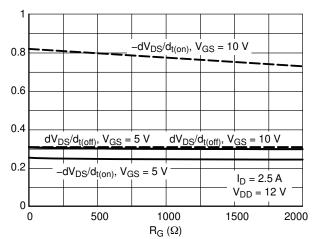


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

DRAIN-SOURCE VOLTAGE SLOPE (V/μs)

TYPICAL PERFORMANCE CURVES

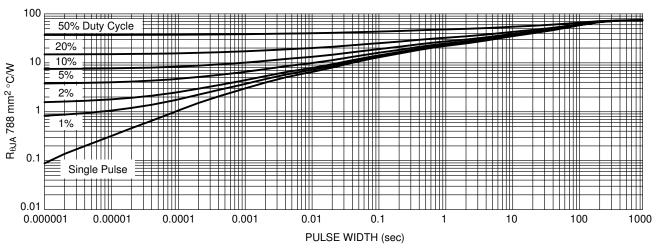


Figure 20. Transient Thermal Resistance - SOT-223 Package

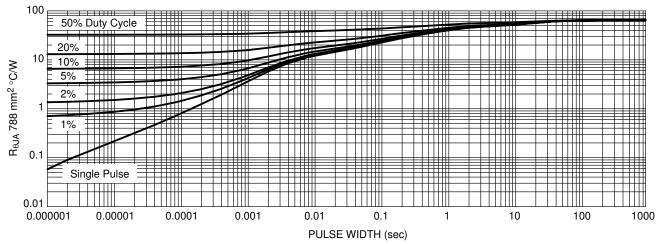


Figure 21. Transient Thermal Resistance - DFN Package

TEST CIRCUITS AND WAVEFORMS

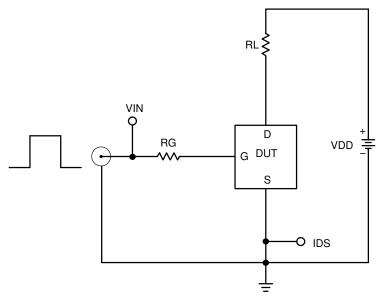


Figure 22. Resistive Load Switching Test Circuit

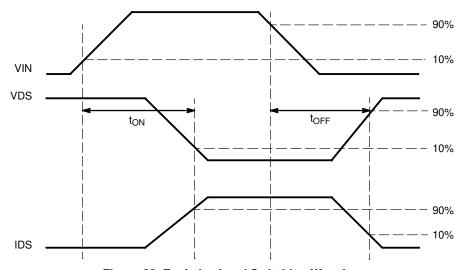


Figure 23. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

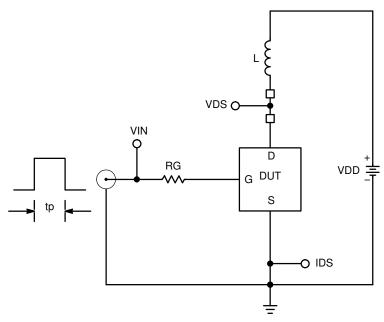


Figure 24. Inductive Load Switching Test Circuit

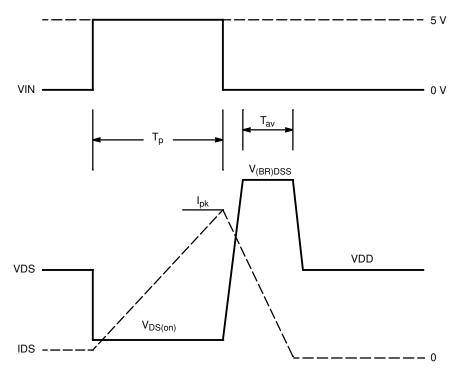


Figure 25. Inductive Load Switching Waveforms

Table 1. ORDERING INFORMATION

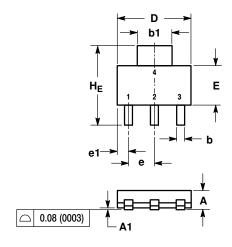
Device	Package	Shipping [†]	
NCV8402STT1G	SOT-223	1000 / Tape & Reel	
NCV8402ASTT1G	(Pb–Free)		
NCV8402STT3G	SOT-223	4000 / Tape & Reel	
NCV8402ASTT3G	(Pb–Free)		
NCV8402AMNT2G	DFN6 (Pb-Free)	2000 / Tape & Reel	
NCV8402AMNWT1G	DFN6 (Pb-Free, Wettable Flank)	3000 / Tape & Reel	

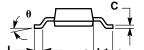
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SOT-223 (TO-261)

CASE 318E-04 ISSUE N





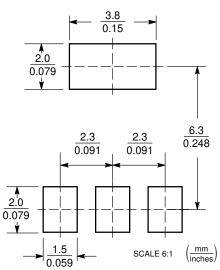
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.50	1.63	1.75	0.060	0.064	0.068	
A1	0.02	0.06	0.10	0.001	0.002	0.004	
b	0.60	0.75	0.89	0.024	0.030	0.035	
b1	2.90	3.06	3.20	0.115	0.121	0.126	
С	0.24	0.29	0.35	0.009	0.012	0.014	
D	6.30	6.50	6.70	0.249	0.256	0.263	
E	3.30	3.50	3.70	0.130	0.138	0.145	
е	2.20	2.30	2.40	0.087	0.091	0.094	
e1	0.85	0.94	1.05	0.033	0.037	0.041	
L	0.20			0.008			
L1	1.50	1.75	2.00	0.060	0.069	0.078	
HE	6.70	7.00	7.30	0.264	0.276	0.287	
_	0.0		4.00	0.0		4.00	

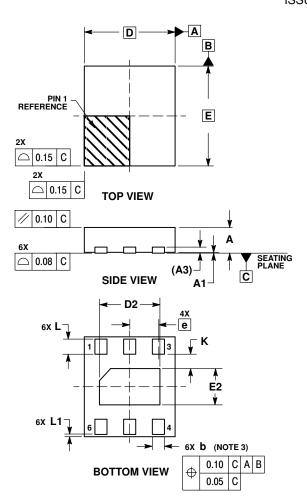
STYLE 3:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

SOLDERING FOOTPRINT



PACKAGE DIMENSIONS

DFN6 3x3.3, 0.95 PITCH CASE 506AX ISSUE O



NOTES:

- NOTES:

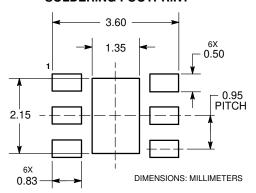
 1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: MILLIMETERS.

 3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 mm
- FROM TERMINAL.
 COPLANARITY APPLIES TO THE EXPOSED PAD
 AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.80		0.90		
A1	0.00		0.05		
A3	0	.20 REF			
b	0.30		0.40		
D	3	.00 BSC	;		
D2	1.90		2.10		
E	3	.30 BSC	;		
E2	1.10		1.30		
е	0.95 BSC				
K	0.20				
L	0.40		0.60		
L1	0.00		0.15		

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

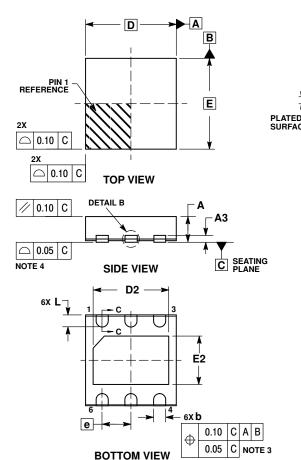
PACKAGE DIMENSIONS

DFN6 3x3, 0.95P CASE 506DK **ISSUE O**

DETAIL B

SECTION C-C

PLATED

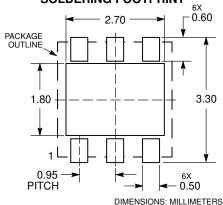


NOTES:

- 1. DIMENSIONS AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMESNION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM THE TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED
- PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α	0.75	0.95			
A1	0.00	0.05			
A3	0.20	REF			
A4	0.05	0.15			
b	0.35	0.45			
D	3.00	BSC			
D2	2.40	2.60			
E	3.00	BSC			
E2	1.50	1.70			
е	0.95 BSC				
L	0.30	0.50			
L3	0.00	0.10			

RECOMMENDED SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdt/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages.

Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative